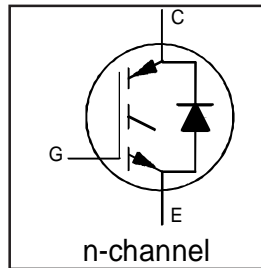


IRG4PH40UD2PbF

INSULATED GATE BIPOLAR TRANSISTOR WITH UltraFast CoPack IGBT
ULTRAFAST SOFT RECOVERY DIODE

Features

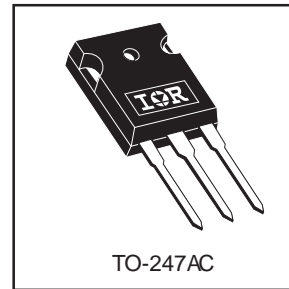
- UltraFast: Optimized for high operating frequencies up to 40 kHz in hard switching, >200 kHz in resonant mode
- New IGBT design provides tighter parameter distribution and higher efficiency than previous generations
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-247AC package
- Lead-Free



| |
|-----------------------------|
| $V_{CES} = 600V$ |
| $V_{CE(on) typ.} = 1.72V$ |
| @ $V_{GE} = 15V, I_C = 20A$ |

Benefits

- Higher switching frequency capability than competitive IGBTs
- Highest efficiency available
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less/no snubbing.



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|--|-----------------------------------|-------|
| V_{CES} | Collector-to-Emitter Voltage | 600 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current | 40 | A |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current | 20 | |
| I_{CM} | Pulse Collector Current ① | 160 | |
| I_{LM} | Clamped Inductive Load current ① | 160 | |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current | 10 | |
| I_{FM} | Diode Maximum Forward Current | 40 | |
| V_{GE} | Gate-to-Emitter Voltage | ± 20 | V |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation | 160 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation | 65 | |
| T_J | Operating Junction and Storage Temperature Range | -55 to +150 | °C |
| T_{STG} | | | |
| | Storage Temperature Range, for 10 sec. | 300 (0.063 in. (1.6mm) from case) | |
| | Mounting Torque, 6-32 or M3 screw | 10 lbf•in (1.1N•m) | |

Thermal / Mechanical Characteristics

| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|---|------|----------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case- IGBT | — | — | 0.77 | °C/W |
| $R_{\theta JC}$ | Junction-to-Case- Diode | — | — | 2.5 | |
| $R_{\theta CS}$ | Case-to-Sink, flat, greased surface | — | 0.24 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient, typical socket mount | — | — | 40 | |
| Wt | Weight | — | 6 (0.21) | — | |

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International
IR Rectifier

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| Parameter | Min. | Typ. | Max. | Units | Conditions | |
|--|---|------|------|-------|--|--|
| V _{(BR)CES} | 600 | — | — | V | V _{GE} = 0V, I _C = 250μA | |
| ΔV _{(BR)CES} /ΔT _J | — | 0.63 | — | V/°C | V _{GE} = 0V, I _C = 1mA (25°C-150°C) | |
| V _{CE(on)} | Collector-to-Emitter Saturation Voltage | — | 1.72 | 2.1 | V | I _C = 20A, V _{GE} = 15V, T _J = 25°C |
| | | — | 2.15 | — | | I _C = 40A, V _{GE} = 15V, T _J = 125°C |
| | | — | 1.7 | — | | I _C = 20A, V _{GE} = 15V, T _J = 150°C |
| V _{GE(th)} | 3.0 | — | 6.0 | | V _{CE} = V _{GE} , I _C = 250μA | |
| ΔV _{GE(th)} /ΔT _J | — | -13 | — | mV/°C | V _{CE} = V _{GE} , I _C = 250μA | |
| g _{fe} | 11 | 18 | — | S | V _{CE} = 100V, I _C = 20A | |
| I _{CES} | Zero Gate Voltage Collector Current | — | — | 250 | μA | V _{GE} = 0V, V _{CE} = 600V |
| | | — | — | 2.0 | | V _{GE} = 0V, V _{CE} = 10V, T _J = 25°C |
| | | — | — | 2500 | | V _{GE} = 0V, V _{CE} = 600V, T _J = 150°C |
| V _{FM} | Diode Forward Voltage Drop | — | 3.4 | 3.8 | V | I _F = 10A, V _{GE} = 0V |
| | | — | 3.3 | 3.7 | | I _F = 10A, V _{GE} = 0V, T _J = 150°C |
| I _{GES} | Gate-to-Emitter Leakage Current | — | — | ±100 | nA | V _{GE} = ±20V |

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

| Parameter | Min. | Typ. | Max. | Units | Conditions | |
|-------------------------|---|------|------|-------|---|--|
| Q _g | — | 110 | 130 | nC | I _C = 20A V _{CC} = 400V V _{GE} = 15V | |
| Q _{ge} | — | 18 | 24 | | | |
| Q _{gc} | — | 36 | 53 | | | |
| t _{d(on)} | — | 23 | — | ns | I _C = 20A, V _{CC} = 600V V _{GE} = 15V, R _G = 10Ω T _J = 25°C Energy losses included "tail" | |
| t _r | — | 27 | — | | | |
| t _{d(off)} | — | 100 | 110 | | | |
| t _f | — | 280 | 340 | | | |
| E _{on} | — | 1440 | — | | | μJ |
| E _{off} | — | 1410 | — | | | |
| E _{tot} | — | 2850 | 3740 | | | |
| t _{d(on)} | — | 22 | — | ns | I _C = 20A, V _{CC} = 600V V _{GE} = 15V, R _G = 10Ω, L = 1.0mH T _J = 150°C Energy losses included "tail" | |
| t _r | — | 32 | — | | | |
| t _{d(off)} | — | 190 | — | | | |
| t _f | — | 630 | — | | | |
| E _{TS} | — | 5360 | — | μJ | | |
| L _E | Internal Emitter Inductance | — | 13 | nH | Measured 5mm from package | |
| C _{ies} | Input Capacitance | — | 2100 | pF | V _{GE} = 0V V _{CC} = 30V f = 1.0MHz | |
| C _{oes} | Output Capacitance | — | 99 | | | |
| C _{res} | Reverse Transfer Capacitance | — | 12 | | | |
| t _{rr} | Diode Reverse Recovery Time | — | 50 | 76 | ns | T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |
| | | — | 72 | 110 | | T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |
| I _{rr} | Diode Peak Reverse Recovery Current | — | 4.4 | 7.0 | A | T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |
| | | — | 5.9 | 8.8 | | T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |
| Q _{rr} | Diode Reverse Recovery Charge | — | 130 | 200 | nC | T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |
| | | — | 250 | 380 | | T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |
| di _(rec) /dt | Diode Peak Rate of Fall of Recovery During t _b | — | 210 | — | A/μs | T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |
| | | — | 180 | — | | T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs |

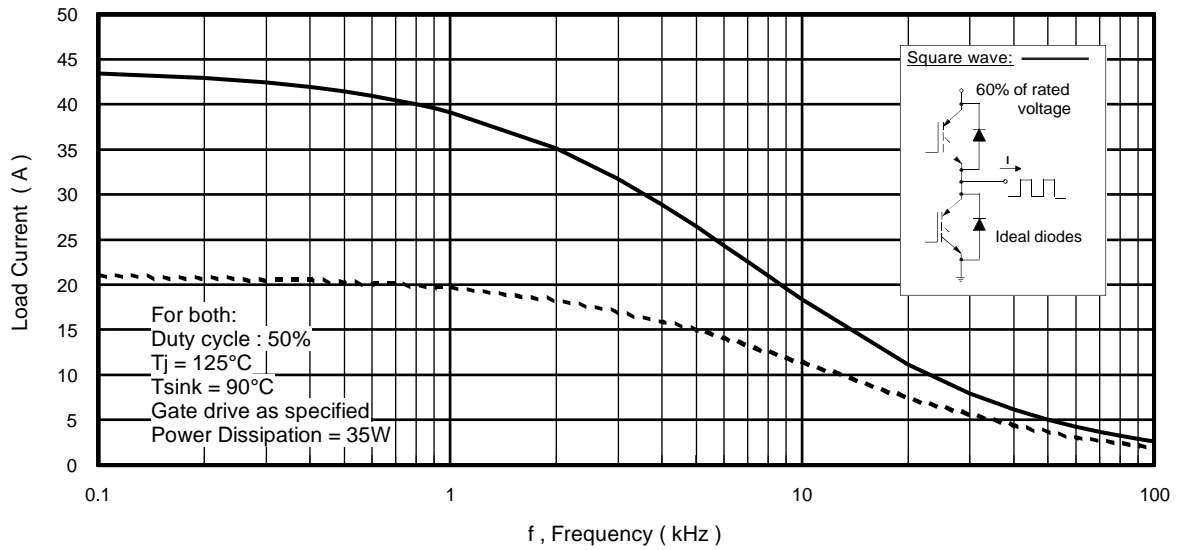


Fig. 1 - Typical Load Current vs. Frequency
 (Load Current = I_{RMS} of fundamental)

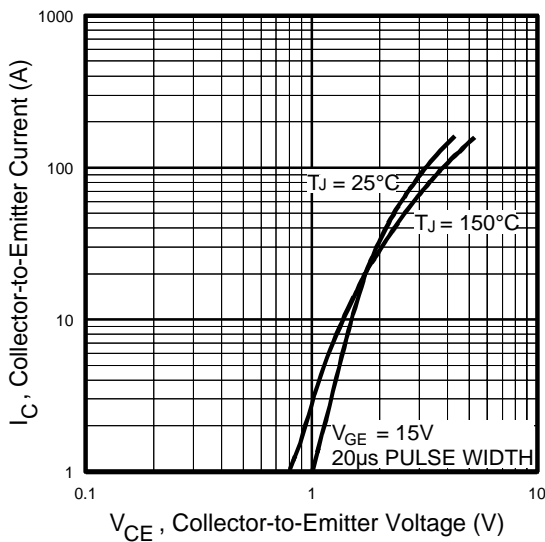


Fig. 2 - Typical Output Characteristics

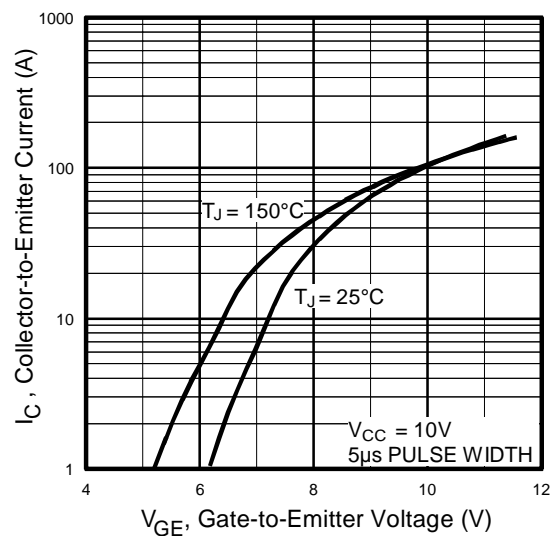


Fig. 3 - Typical Transfer Characteristics

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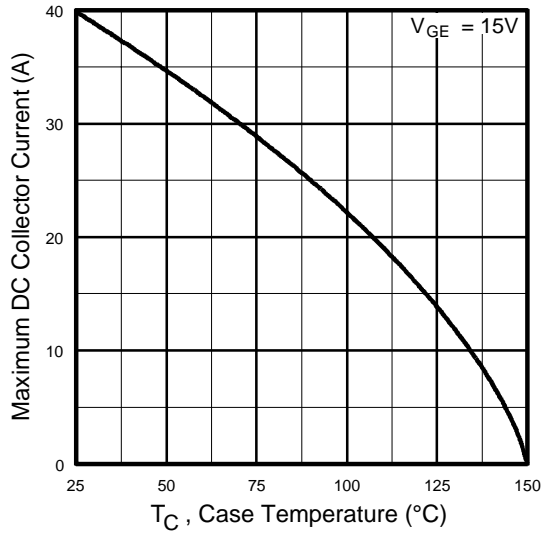


Fig. 4 - Maximum Collector Current vs. Case Temperature

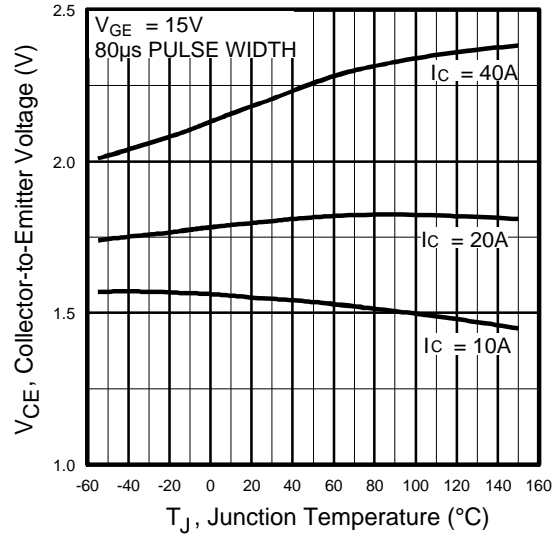


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

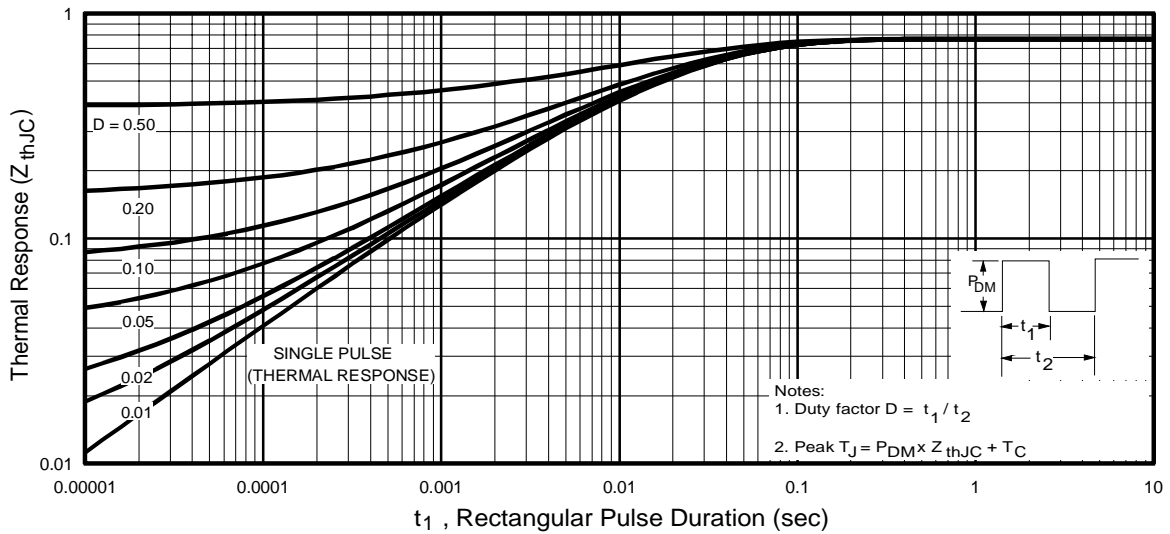


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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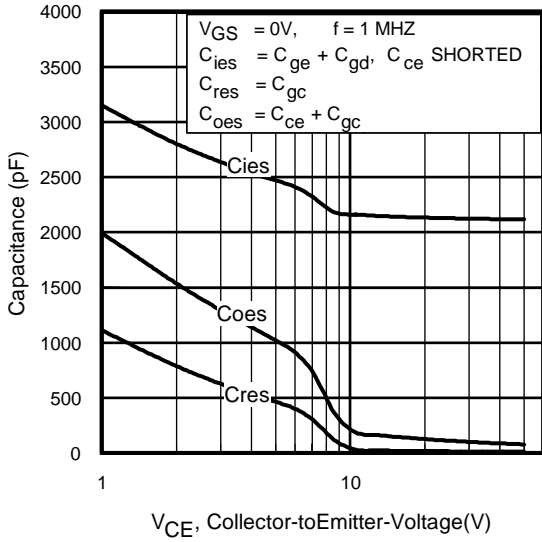


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

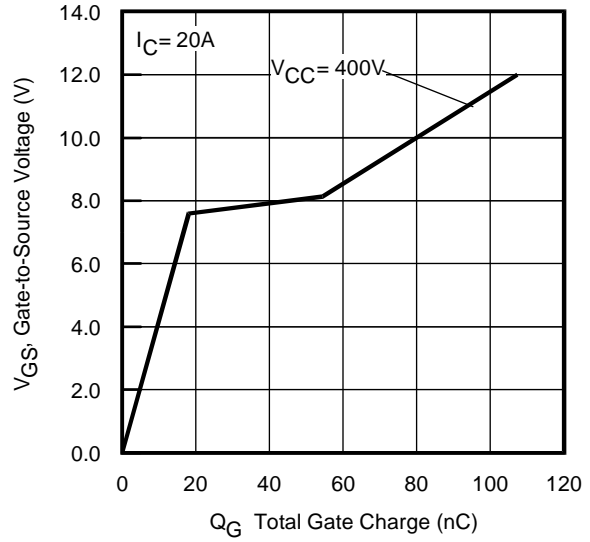


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

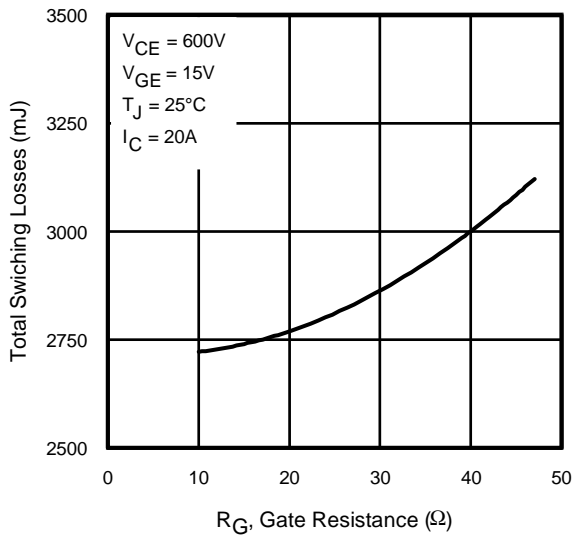


Fig. 9 - Typical Switching Losses vs. Gate Resistance

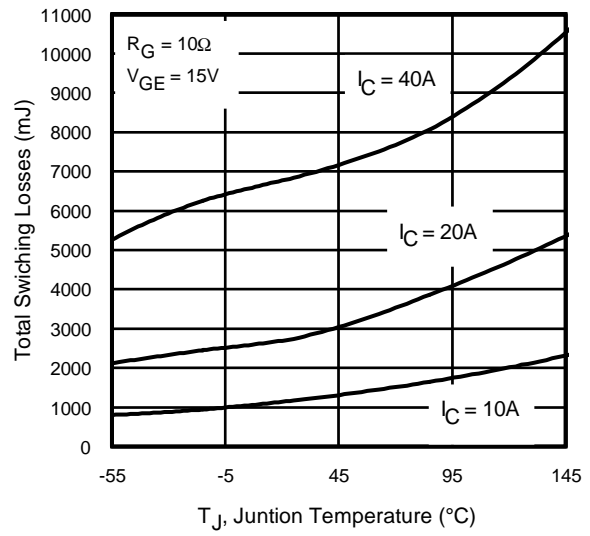


Fig. 10 - Typical Switching Losses vs. Junction Temperature

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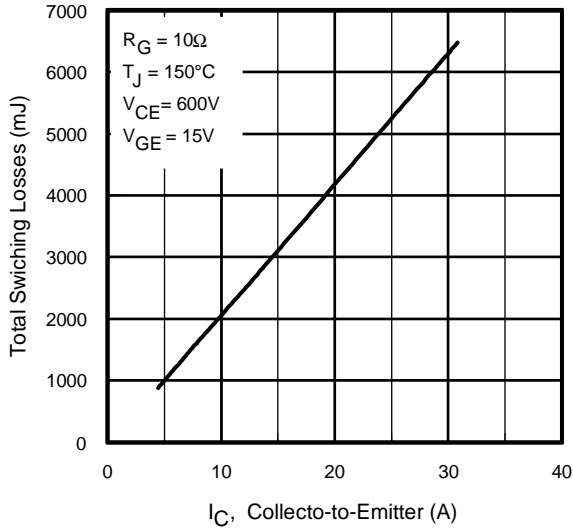


Fig. 11 - Typical Switching Losses vs. Collector-to-Emitter Current

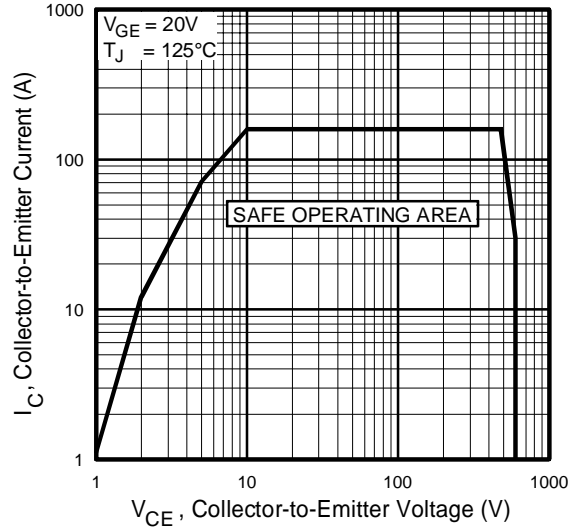


Fig. 12 - Turn-Off SOA

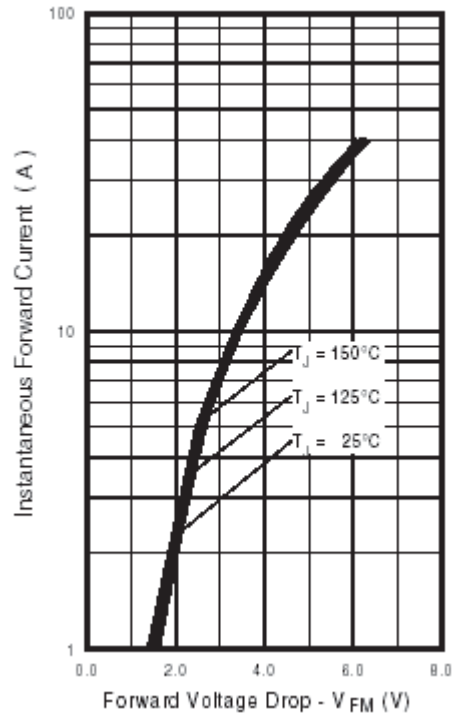


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

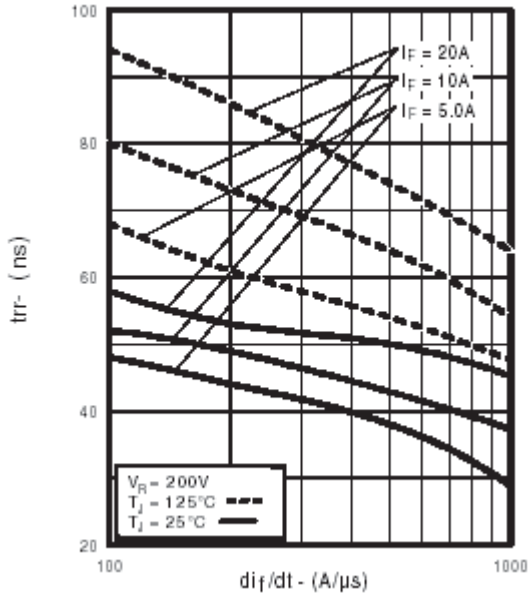


Fig. 14 - Typical Reverse Recovery vs. di_T/dt

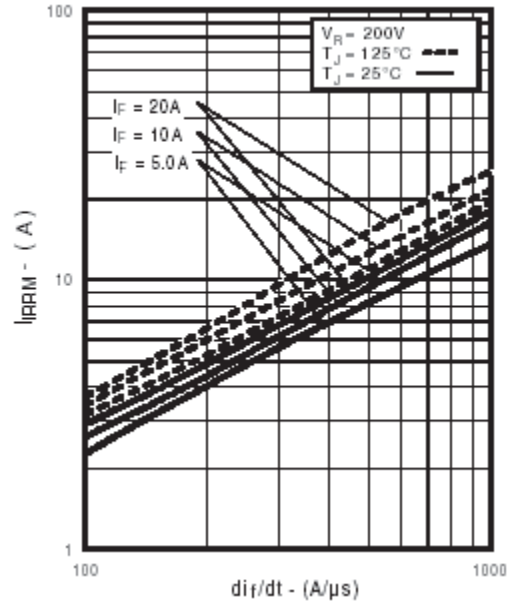


Fig. 15 - Typical Recovery Current vs. di_T/dt

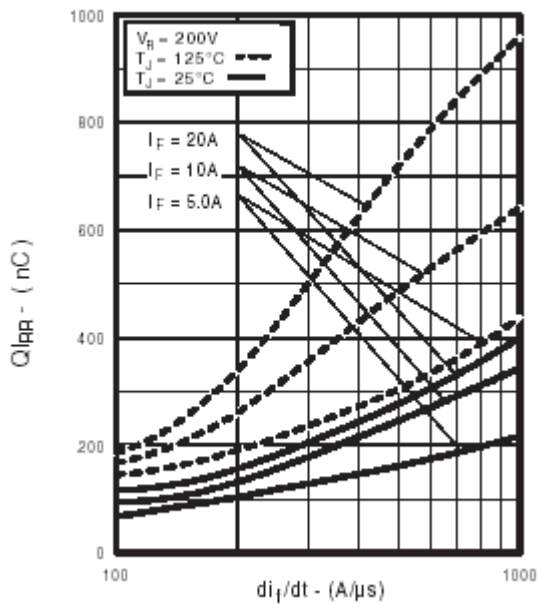


Fig. 16 - Typical Stored Charge vs. di_T/dt

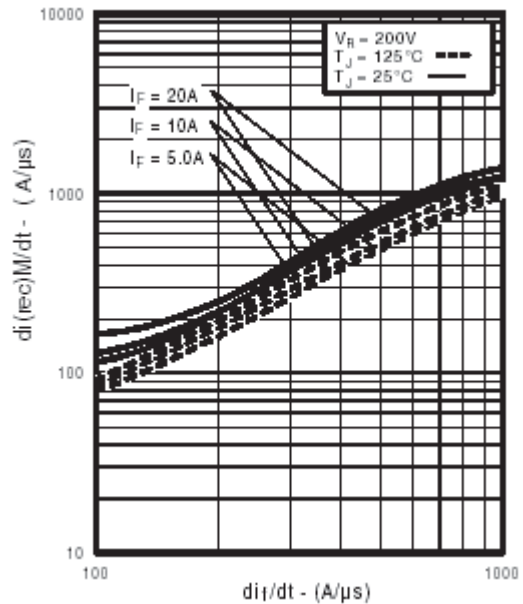


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_T/dt

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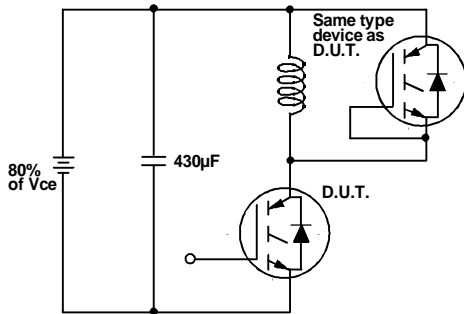


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

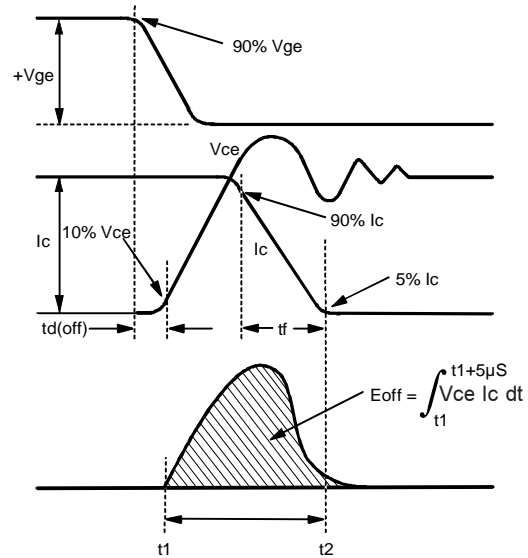


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

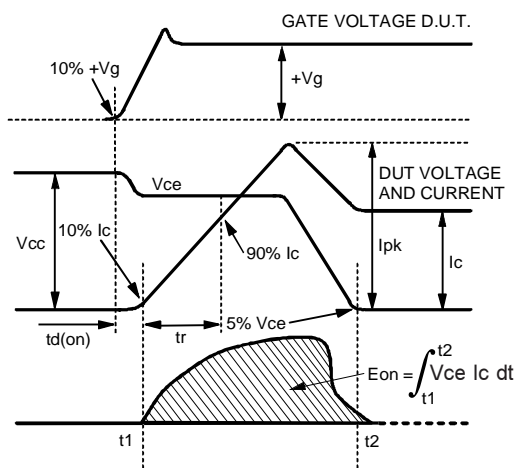


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

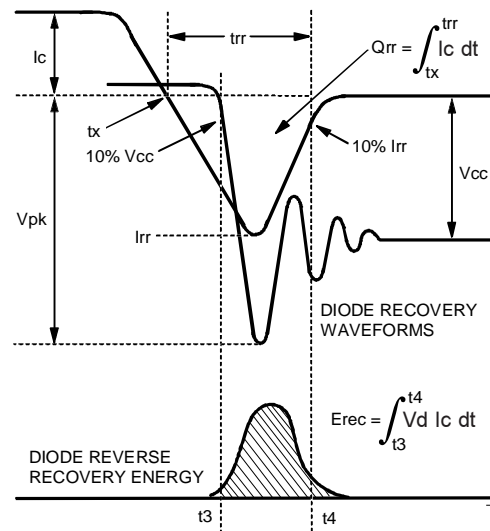


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

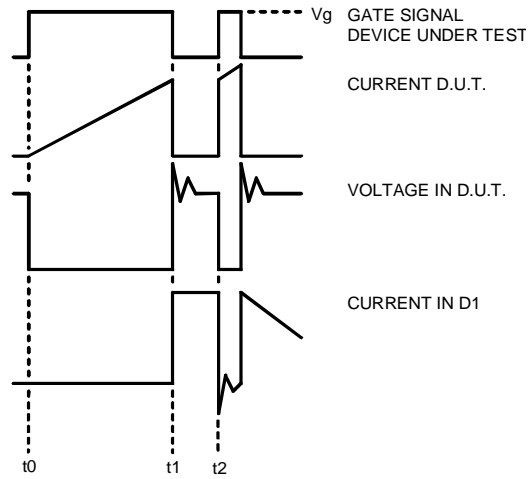


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

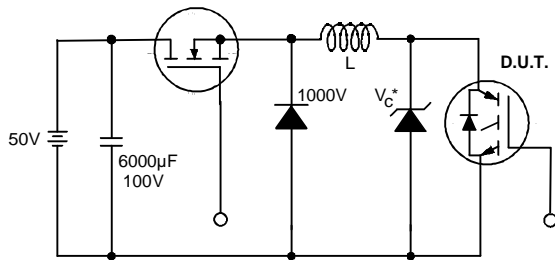


Figure 19. Clamped Inductive Load Test Circuit

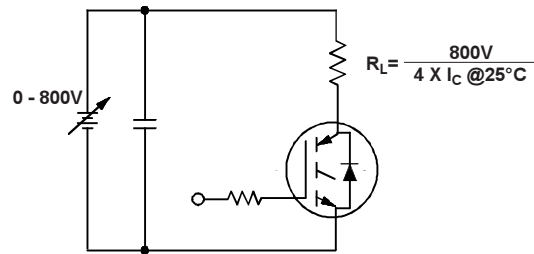
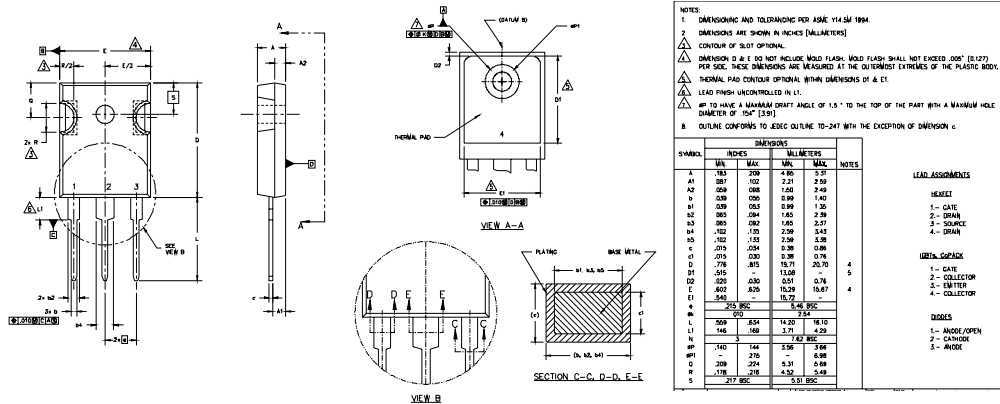


Figure 20. Pulsed Collector Current Test Circuit

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TO-247AC Package Outline

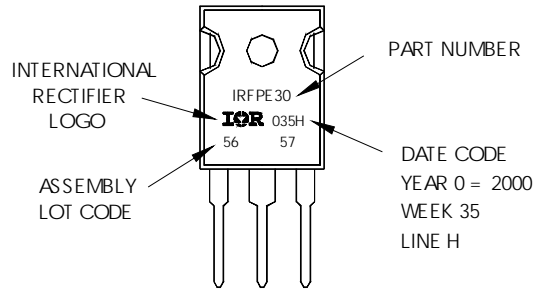
Dimensions are shown in millimeters (inches)



TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFP630
WITH ASSEMBLY
LOT CODE 5657
ASSEMBLED ON WW 35, 2000
IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position indicates "Lead-Free"



Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- ② $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G=10\Omega$ (figure 19)
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.

TO-247AC package is not recommended for Surface Mount Application.

Data and specifications subject to change without notice.
This product has been designed and qualified for Industrial market.
Qualification Standards can be found on IR's Web site.